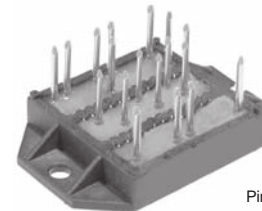
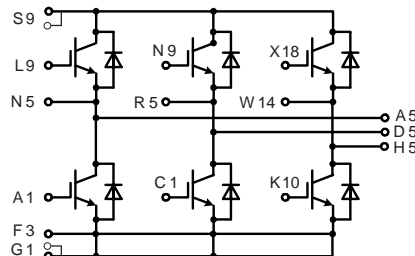


IGBT Module

Sixpack in ECO-PAC 2

$I_{C25} = 31 \text{ A}$
 $V_{CES} = 600 \text{ V}$
 $V_{CE(sat) \text{ typ.}} = 1.9 \text{ V}$



Pin arrangement see outlines

IGBTs

| Symbol | Conditions | Maximum Ratings | |
|----------------------------|--|--|----|
| V_{CES} | $T_{VJ} = 25^{\circ}\text{C to } 150^{\circ}\text{C}$ | 600 | V |
| V_{GES} | | ± 20 | V |
| I_{C25} | $T_C = 25^{\circ}\text{C}$ | 31 | A |
| I_{C80} | $T_C = 80^{\circ}\text{C}$ | 21 | A |
| I_{CM} V_{CEK} | $V_{GE} = \pm 15 \text{ V}; R_G = 47 \Omega; T_{VJ} = 125^{\circ}\text{C}$ RBSOA, Clamped inductive load; $L = 100 \mu\text{H}$ | 40 | A |
| t_{SC} (SCSOA) | | $V_{CE} = 600 \text{ V}; V_{GE} = \pm 15 \text{ V}; R_G = 47 \Omega; T_{VJ} = 125^{\circ}\text{C}$ non-repetitive | 10 |
| P_{tot} | $T_C = 25^{\circ}\text{C}$ | 100 | W |

Features

- NPT IGBT's
 - positive temperature coefficient of saturation voltage
 - fast switching
- FRED diodes
 - fast reverse recovery
 - low forward voltage
- Industry Standard Package
 - solderable pins for PCB mounting
 - isolated DCB ceramic base plate

Typical Applications

- AC drives
- power supplies with power factor correction

| Symbol | Conditions | Characteristic Values ($T_{VJ} = 25^{\circ}\text{C}$, unless otherwise specified) | | |
|---|--|--|------|--------------|
| | | min. | typ. | max. |
| $V_{CE(sat)}$ | $I_C = 20 \text{ A}; V_{GE} = 15 \text{ V}; T_{VJ} = 25^{\circ}\text{C}$ $T_{VJ} = 125^{\circ}\text{C}$ | 1.9 | 2.2 | V V |
| $V_{GE(th)}$ | $I_C = 0.5 \text{ mA}; V_{GE} = V_{CE}$ | 4.5 | | 6.5 V |
| I_{CES} | $V_{CE} = V_{CES}; V_{GE} = 0 \text{ V}; T_{VJ} = 25^{\circ}\text{C}$ $T_{VJ} = 125^{\circ}\text{C}$ | 0.7 | | 0.6 mA mA |
| I_{GES} | $V_{CE} = 0 \text{ V}; V_{GE} = \pm 20 \text{ V}$ | | | 100 nA |
| $t_{d(on)}$ t_r $t_{d(off)}$ t_f | Inductive load, $T_{VJ} = 125^{\circ}\text{C}$ $V_{CE} = 300 \text{ V}; I_C = 10 \text{ A}$ $V_{GE} = \pm 15 \text{ V}; R_G = 82 \Omega$ | | 50 | ns |
| E_{on} | | | 55 | ns |
| E_{off} | | | 300 | ns |
| C_{ies} | | | 30 | ns |
| Q_{Gon} | | | 0.9 | mJ |
| | | 0.7 | mJ | |
| C_{ies} | $V_{CE} = 25 \text{ V}; V_{GE} = 0 \text{ V}; f = 1 \text{ MHz}$ | 1100 | | pF |
| Q_{Gon} | $V_{CE} = 300 \text{ V}; V_{GE} = 15 \text{ V}; I_C = 20 \text{ A}$ | 65 | | nC |
| R_{thJC} | (per IGBT) | | 1.3 | K/W |
| R_{thJH} | with heatsink compound (0.42 K/m.K; 50 μm) | 2.5 | | K/W |

IXYS reserves the right to change limits, test conditions and dimensions.

© 2003 IXYS All rights reserved

IXYS Semiconductor GmbH
 Edisonstr. 15, D-68623 Lampertheim
 Phone: +49-6206-503-0, Fax: +49-6206-503627

www.ixys.net

IXYS Corporation
 3540 Bassett Street, Santa Clara CA 95054
 Phone: (408) 982-0700, Fax: 408-496-0670

Diodes

| Symbol | Conditions | Maximum Ratings | |
|-----------|--------------------------|-----------------|---|
| I_{F25} | $T_C = 25^\circ\text{C}$ | 35 | A |
| I_{F80} | $T_C = 80^\circ\text{C}$ | 22 | A |

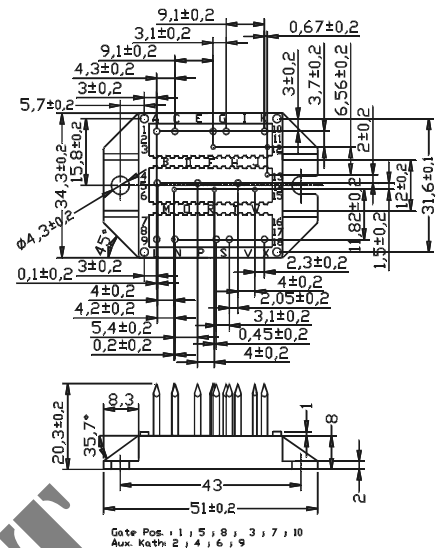
| Symbol | Conditions | Characteristic Values | | |
|--------------------------|---|-----------------------|------|----------------|
| | | min. | typ. | max. |
| V_F | $I_F = 20\text{ A}; T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = 125^\circ\text{C}$ | 1.9 | 2.1 | V |
| I_{RM} t_{rr} | } $I_F = 15\text{ A}; di_F/dt = -400\text{ A}/\mu\text{s}; T_{VJ} = 125^\circ\text{C}$ $V_R = 300\text{ V}; V_{GE} = 0\text{ V}$ | 13 | | A |
| | | 90 | | ns |
| R_{thJC} R_{thJH} | with heatsink compound (0.42 K/m.K; 50 μm) | 4.6 | | 2.3 K/W K/W |

Data according to IEC 60747 and refer to a single diode unless otherwise stated.

Component

| Symbol | Conditions | Maximum Ratings | |
|------------|--|-----------------|------------------|
| T_{VJ} | | -40...+150 | $^\circ\text{C}$ |
| T_{stg} | | -40...+125 | $^\circ\text{C}$ |
| V_{ISOL} | $I_{ISOL} \leq 1\text{ mA}; 50/60\text{ Hz}; t = 1\text{ s}$ | 3600 | V~ |
| M_d | mounting torque (M4) | 1.5 - 2.0 | Nm lb.in. |
| a | Max. allowable acceleration | 50 | m/s^2 |

| Symbol | Conditions | Characteristic Values | | |
|--------|--|-----------------------|------|------|
| | | min. | typ. | max. |
| d_s | Creepage distance on surface (Pin to heatsink) | 11.2 | | mm |
| d_A | Strike distance in air (Pin to heatsink) | 11.2 | | mm |
| Weight | | 24 | | g |

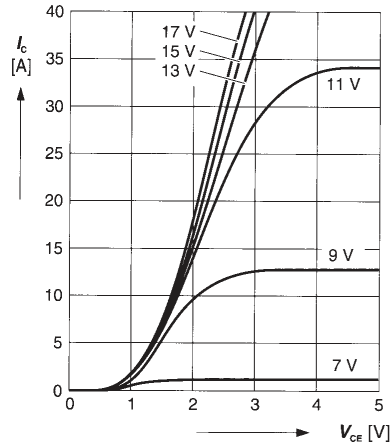
Dimensions in mm (1 mm = 0.0394")


IGBT

Typ. output characteristics

$$I_C = f(V_{CE})$$

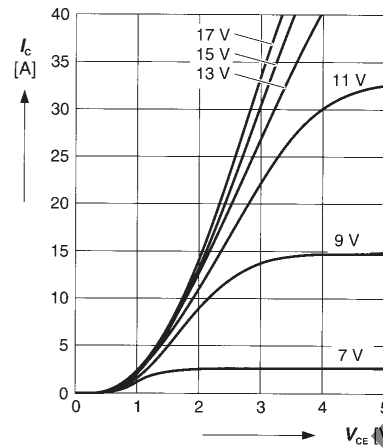
parameter: $t_p = 250 \mu s$; $T_j = 25^\circ C$



Typ. output characteristics

$$I_C = f(V_{CE})$$

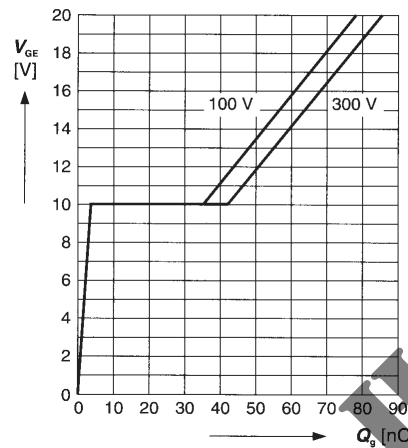
parameter: $t_p = 250 \mu s$; $T_j = 125^\circ C$



Typ. gate charge

$$V_{GE} = f(Q_g)$$

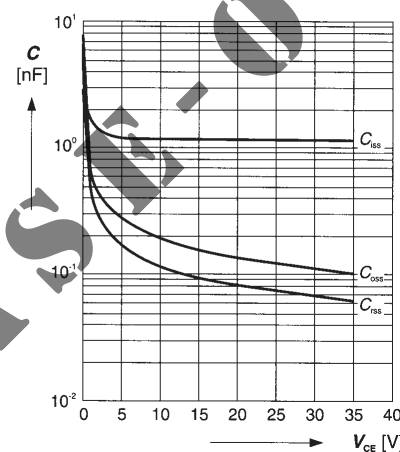
parameter: $I_{C,puls} = 20 A$



Typ. capacitances

$$C = f(V_{CE})$$

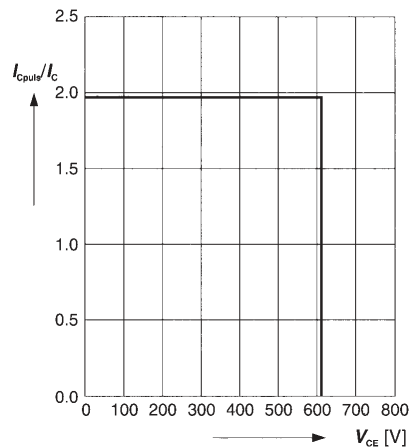
parameter: $V_{GE} = 0 V$; $f = 1 MHz$



Reverse biased safe operating area

$$I_{C,puls} = f(V_{CE}), T_j = 150^\circ C$$

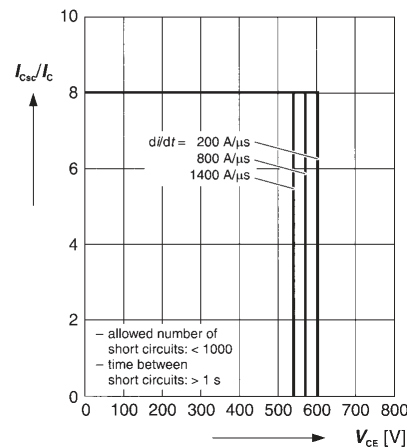
parameter: $V_{GE} = 15 V$



Short circuit safe operating area

$$I_{C,sc} = f(V_{CE}), T_j = 150^\circ C$$

parameter: $V_{GE} = \pm 15 V$; $t_{sc} \le 10 \mu s$; $L < 50 nH$

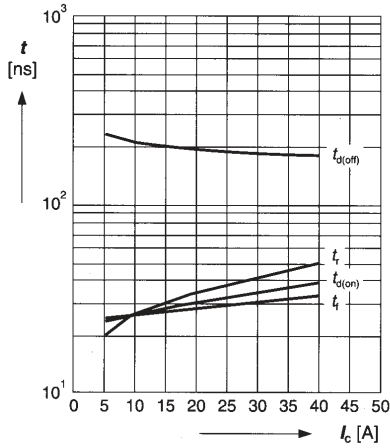


IXYS reserves the right to change limits, test conditions and dimensions.

IGBT

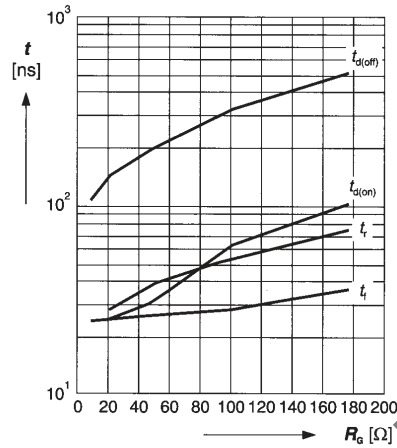
Typ. switching time

$t = f(I_C)$, inductive load, $T_j = 125^\circ\text{C}$
 parameter: $V_{CE} = 300\text{ V}$; $V_{GE} = \pm 15\text{ V}$; $R_G = 47\ \Omega$



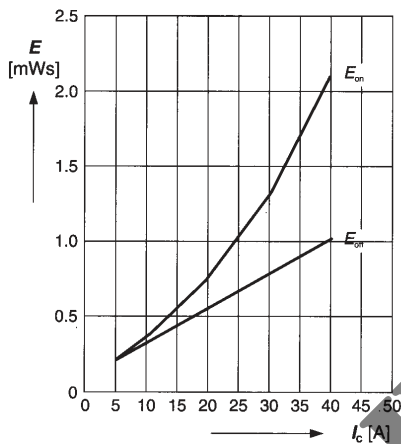
Typ. switching time

$t = f(R_G)$, inductive load, $T_j = 125^\circ\text{C}$
 parameter: $V_{CE} = 300\text{ V}$; $V_{GE} = \pm 15\text{ V}$; $I_C = 20\text{ A}$



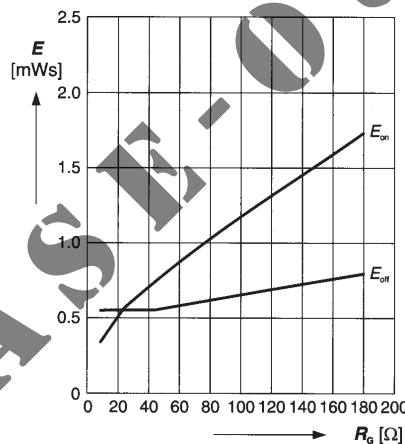
Typ. switching losses

$E = f(I_C)$, inductive load, $T_j = 125^\circ\text{C}$
 parameter: $V_{CE} = 300\text{ V}$; $V_{GE} = \pm 15\text{ V}$; $R_G = 47\ \Omega$

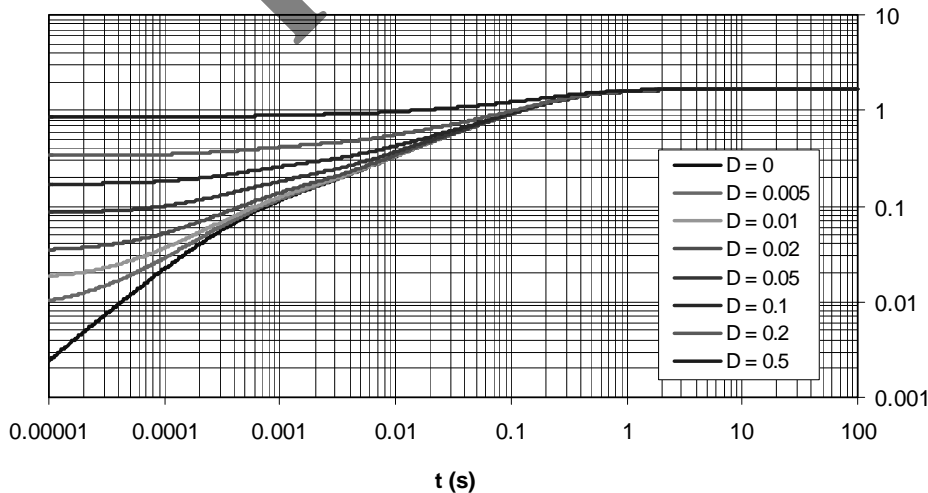


Typ. switching losses

$E = f(R_G)$, inductive load, $T_j = 125^\circ\text{C}$
 parameter: $V_{CE} = 300\text{ V}$; $V_{GE} = \pm 15\text{ V}$; $I_C = 20\text{ A}$



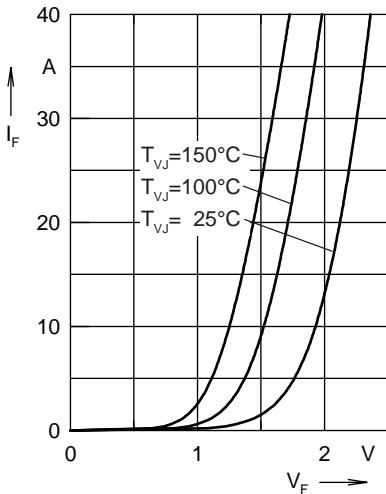
Transient thermal resistance junction to heatsink



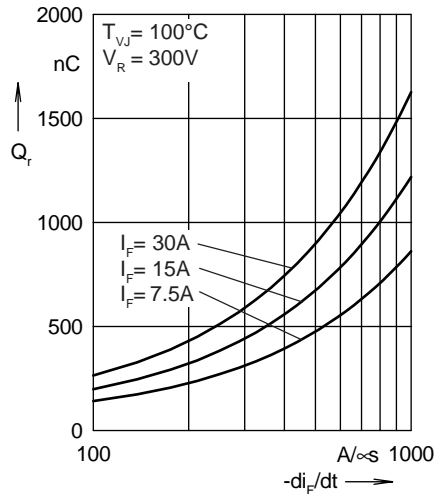
(Z_{thjH} is measured using 50 μm thermal grease)

IGBT
 $Z_{thjH}[\text{K/W}]$

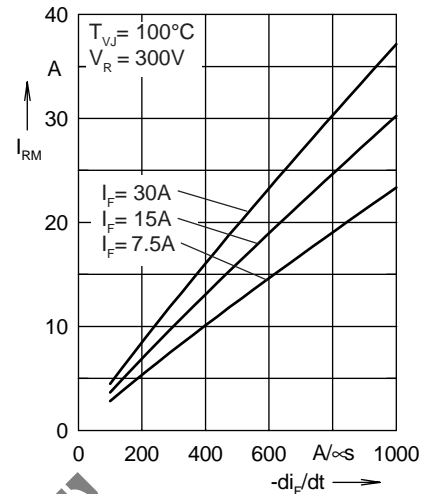
Diode



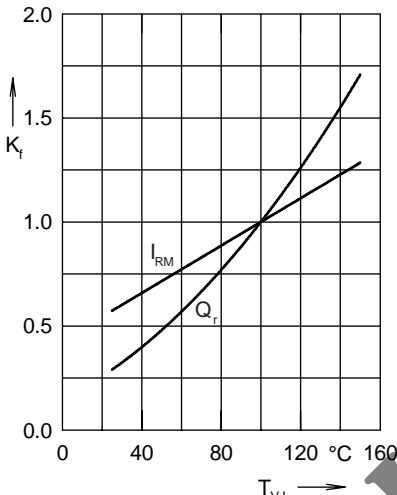
Forward current I_F versus V_F



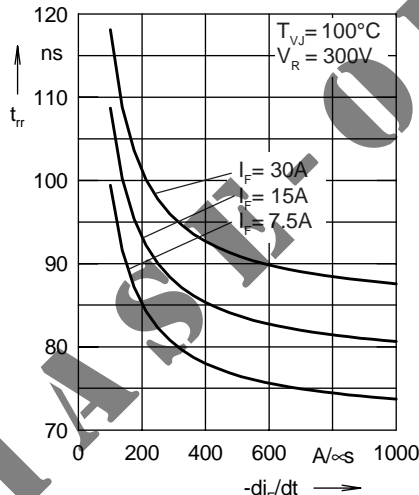
Reverse recovery charge Q_r versus $-di_F/dt$



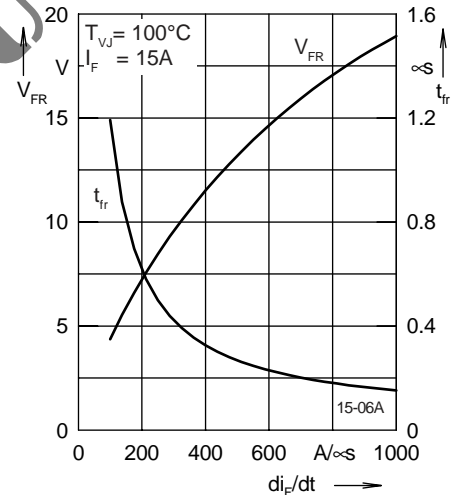
Peak reverse current I_{RM} versus $-di_F/dt$



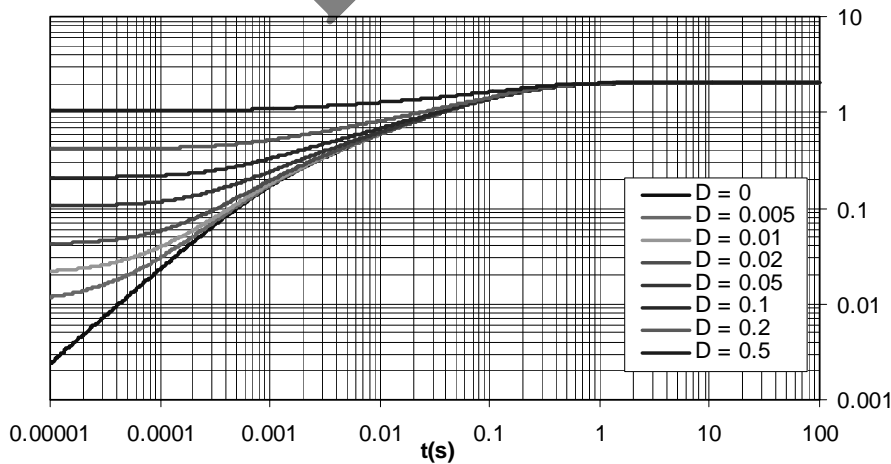
Dynamic parameters Q_r , I_{RM} versus T_{VJ}



Recovery time t_{rr} versus $-di_F/dt$



Peak forward voltage V_{FR} and t_{rr} versus di_F/dt



Transient thermal resistance junction to heatsink

(Z_{thJH} is measured using 50 μm thermal grease)

FRED
 Z_{thJH} [K/W]

IXYS reserves the right to change limits, test conditions and dimensions.

© 2003 IXYS All rights reserved